Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/605,762	CHEN ET AL.	
Examiner	Art Unit	
Vincent T. Tran	2115	

SEARCHED			
Class	Subclass	Date	Examiner
713	1	1/3/2006	VT
713	2	1/6/2006	VT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR		()
	DATE	EXMR
EAST - see attachment	1/3/2006	VT
EAST - see attachment	1/6/2006	VT